

Dual N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$	I _D (A) ^a	Q _g (Typ.)			
60	0.048 at V _{GS} = 10 V	4.2	4.9			
00	0.060 at V _{GS} = 4.5 V	3.6	4.5			

TSOP-6

Top View

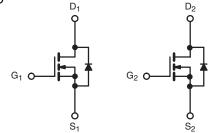
FEATURES • Halogen-fre

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_g and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



APPLICATIONS

- CCFL Inverter
- DC/DC Converter
- HDD



N-Channel MOSFET

N-Channel MOSFET

	_			_	
	G1	1	6		D1
3 mm 	S2 🔲	2	5		S1
<u> </u>	G2	3	4		D2
	 	— 2.85 mi	m —		

ABSOLUTE MAXIMUM RATINGS $(T_A = 2$	25 °C, unless othe	rwise noted)		
Parameter	Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 20] '
	T _C = 25 °C		4.2	
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	,	3.6	1
Continuous Diam Guitent (1) = 130 °C)	T _A = 25 °C	l _D -	4.0 ^{b, c}	1
	T _A = 70 °C		3.0 ^{b, c}]
Pulsed Drain Current (10 µs Pulse Width)		I _{DM}	16	Α
Source-Drain Current Diode Current	T _C = 25 °C	I _S	2.6	
Source-Drain Current Diode Current	T _A = 25 °C		1.6 ^{b, c}]
Pulsed Source-Drain Current	I _{SM}	16		
Single Pulse Avalanche Current L = 0.1 mH		I _{AS}	10	
Single Pulse Avalanche Energy	L=0.11111	E _{AS}	5	
	T _C = 25 °C	P _D	2.8	
Maximum Power Dissipation	T _C = 70 °C		1.8	w
Maximum Fower Dissipation	T _A = 25 °C		2 ^{b, c}	7
	T _A = 70 °C		1.28 ^{b, c}	1
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS							
Parameter		Symbol	Тур.	Max.	Unit		
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	49	62.5	°C/W		
Maximum Junction-to-Foot (Drain)	Steady-State	R_{thJF}	30	40] 5/**		

Notes:

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 120 °C/W.



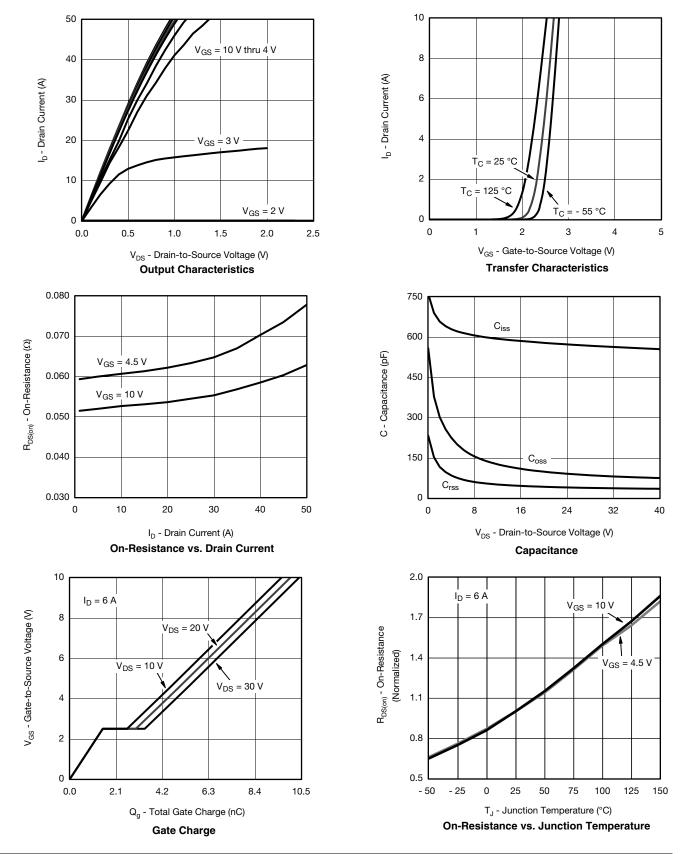
Parameter	Symbol	Test Conditions	Min.	Typ. ^a	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	60			V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = 250 μA		49		mV/°C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$			- 5.2		
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			100	nA
Zara Cata Valtana Brain Correct		V _{DS} = 60 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10	- μΑ
On-State Drain Current ^b	I _{D(on)}	V _{DS} = 5 V, V _{GS} = 10 V	20			Α
h	В	$V_{GS} = 10 \text{ V}, I_D = 4.0 \text{A}$		0.048		Ω
Drain-Source On-State Resistance ^b	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 3.0 \text{A}$		0.060		
Forward Transconductance ^b	9 _{fs}	V _{DS} = 15 V, I _D = 4.0A		35		S
Dynamic ^a	•	<u> </u>		1		
Input Capacitance	C _{iss}			580		pF
Output Capacitance	C _{oss}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ MHz}$		100		
Reverse Transfer Capacitance	C _{rss}	1		42		
T. 10 . 0	Q _g	V _{DS} = 30 V, V _{GS} = 10 V, I _D = 4.0 A		10	15	nC
Total Gate Charge				4.9	7.4	
Gate-Source Charge	Q _{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 4.0 \text{ A}$		1.5		
Gate-Drain Charge	Q _{gd}	1		1.5		
Gate Resistance	R _g	f = 1 MHz	0.6	2.7	5.4	Ω
Turn-On Delay Time	t _{d(on)}			7	14	
Rise Time	t _r	$V_{DD} = 30 \text{ V}, R_{L} = 2 \Omega$		9	18	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 4.0 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		16	32	
Fall Time	t _f	1		8	16	
Turn-On Delay Time	t _{d(on)}			12	24	ns
Rise Time	t _r	V_{DD} = 20 V, R_L = 2 Ω		10	20	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 7.0 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		13	26	
Fall Time	t _f			8	16	1
Drain-Source Body Diode Characteristi	cs					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.6	_
Pulse Diode Forward Current ^a	I _{SM}				50	A
Body Diode Voltage	V _{SD}	I _S = 3 A		0.77	1.2	V
Body Diode Reverse Recovery Time	t _{rr}			15	30	ns
Body Diode Reverse Recovery Charge	Q _{rr}			7.5	15	nC
Reverse Recovery Fall Time	t _a			9		
Reverse Recovery Rise Time	t _b			6		ns

Notes:

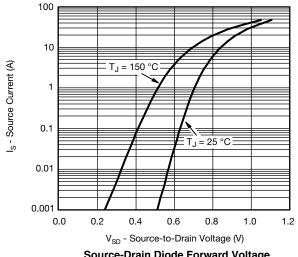
- a. Guaranteed by design, not subject to production testing. b. Pulse test; pulse width \leq 300 μs , duty cycle \leq 2 %.

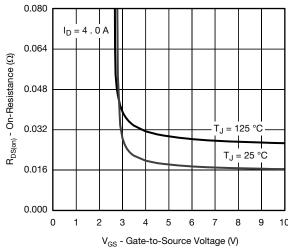
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



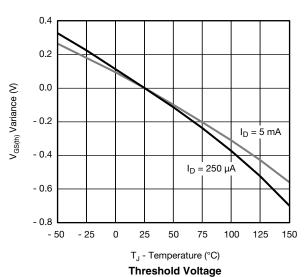




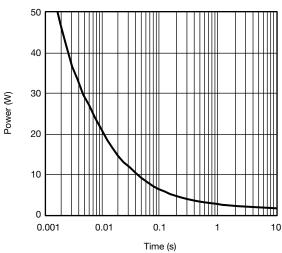




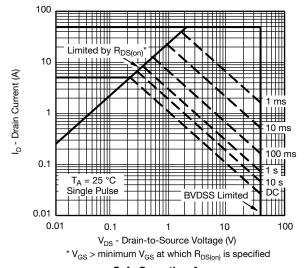
Source-Drain Diode Forward Voltage



On-Resistance vs. Gate-to-Source Voltage

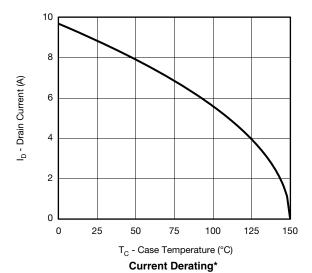


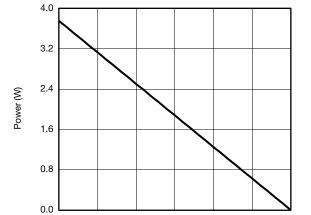
Single Pulse Power, Junction-to-Ambient

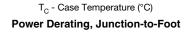


Safe Operating Area





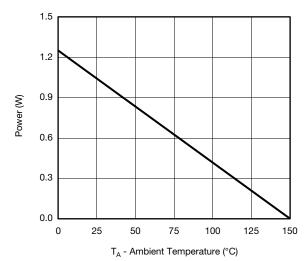




75

100

125



Power Derating, Junction-to-Ambient

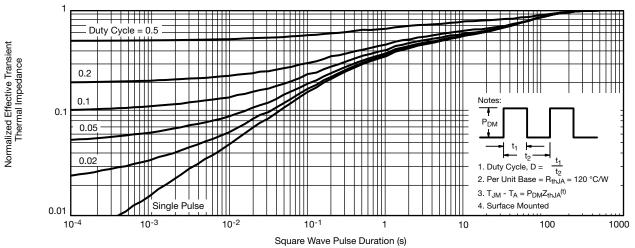
服务热线:400-655-8788

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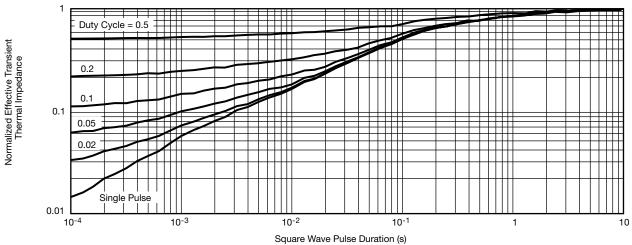
25

 $^{^{\}star}$ The power dissipation P_D is based on T_{J(max)} = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



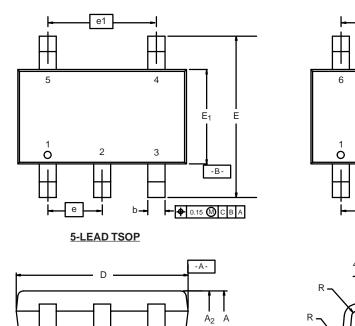
Normalized Thermal Transient Impedance, Junction-to-Foot



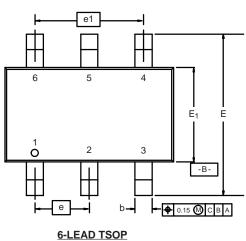
TSOP: 5/6-LEAD

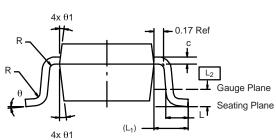
JEDEC Part Number: MO-193C

a 0.08 C



-C- A₁



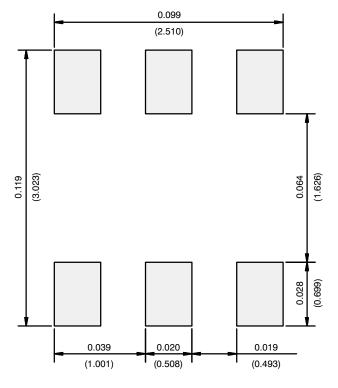


	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A ₁	0.01	-	0.10	0.0004	-	0.004	
A ₂	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E ₁	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.95 BSC		0.0374 BSC			
e ₁	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L ₁		0.60 Ref		0.024 Ref			
L ₂	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
θ1		7° Nom		7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							

Seating Plane



RECOMMENDED MINIMUM PADS FOR TSOP-6



Recommended Minimum Pads Dimensions in Inches/(mm)



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